PHILIP MORRIS U.S.A.

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120 PARK AVENUE, NEW YORK, N.Y 10017

to:

Tom Garguilo

DATE: November 8, 1989

FROM

Carolyn Levy

SUBJECT:

RESEARCH RELATED TO "FREE"

January 1988

Focus Groups - New York City

Merit Free Ads

Shown to assess communication and trial interest.

February 1988

In-Depths - New York/Chicago

Freeport and Next Ads

Shown to smokers to assess communication/image/

interest.

September 1988

Name Test - Geographically dispersed markets

Next, Princeton, Free, Freeport, Select,

Next from Merit

To assess liking and fit with concept.

October 1988

Name Test - Geographically dispersed markets

Select, Concord, Free, Sigma, Next

To asses liking and interest in trying.

October 20, 1988

In-Depths - New York Metro

Merit Free/Next/Princeton Ads

Shown to assess communication/image/interest.

December 1988/

January 1989

Name Test II - Geographically dispersed markets

Merit Free, Next from Merit, Merit Next

To assess liking and interest in trying.

January 1989

Ad/One Stick - Geographically dispersed markets

Next and Merit Free Ads

Shown to respondents and given one cigarette to

smoke assess interest/market potential.

March 1989

Ad/Pack - Geographically dispersed markets

Merit Free and Next Ads/Product

Given to smokers to assess interest/market

potential.

July 1989

Next Extended Use Test - National Sample

Next/Free Plus Process

To assess long term appeal of Next cigarettes.

Aug/Sept. 1989

Test Market Tracking - 4 Test Markets

Next/Merit De-Nic Free Plus Process

To assess awareness, trial, purchase and conversion

to Next/Merit De-Nic.

2043962235

October 1989

Extract Name Test - Geographically dispersed markets

Free Style, Free Nyx, Nicotrol, Nicolean, Nature Plus, Flavor Max, PuraTaste, Free Plus, Pura-Flavor, UnicFree, TechNic, SuperTech To assess liking of names to describe extraction process.

November 1989

HTI Monadic Test - National Sample
Next/Free Plus Process
To asses consumer reaction to name/package/product.

Carol-leny

CL/et

cc: D. Beran

K. Eisen

J. Scully

M. Verscai

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